

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10629640	AMER, MAHER
	<b>Examiner</b>  La Forgia, Christian	<b>Art Unit</b>  2131

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
380	28 AND parallel with scrambl\$3	11/30/06	clf
380	210 AND parallel with scrambl\$3	11/30/06	clf
380	268 AND parallel with scrambl\$3	11/30/06	clf

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East Search - seen enclosed printout	11/28/06	clf
IEEE Search	11/28/06	clf
ACM Search	11/28/06	clf
Google Search	11/28/06	clf
Inventor Search	11/28/06	clf
Assignee Search	11/28/06	clf
Cases Reviewed for Double Patenting: 10/629,644	11/28/06	clf
EIC - for DW Choi document	11/28/06	clf

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>